


Search Notes 	Application/Control No. 10702449	Applicant(s)/Patent Under Reexamination MORISHITA, TAKUYA
	Examiner Werner, David N	Art Unit 2621

SEARCHED

Class	Subclass	Date	Examiner
386	52, 53, 98	5/29/2007	DNW
375	240.13	5/30/2007	DNW
386	55	6/1/2007	DNW
386	52, 53	10/31/2007	DNW

SEARCH NOTES

Search Notes	Date	Examiner
EAST	5/29/2007	DNW
Esp@cenet	5/29/2007	DNW
E-mail to Thai Tran regarding allowability	6/1/2007	DNW
Double-Patent check	6/4/2007	DNW
EAST	10/31/2007	DNW
Espacenet	11/1/2007	DNW
Espacenet, ISR for W0 01/35411 A1 (same as cited Lin et al. reference) searched	5/5/2008	DNW
IEEE Xplore	5/5/2008	DNW

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner